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Ion Beam Production with Sub-milligram Samples of Material from an ECR Source for AMS

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Current Accelerator Mass Spectroscopy (AMS) experiments at the ATLAS facility at Argonne National Laboratory push us to improve the ion source performance with a large number of samples and a need to minimize cross contamination. These experiments can require the creation of ion beams from as little as a few micrograms of material. These low concentration samples push the limit of our current efficiency and stability capabilities of the Electron Cyclotron Resonance Ion Source. A combination of laser ablation and sputtering techniques coupled with a new multi-sample changer have been used to meet this demand. We will discuss performance, stability, and consumption rates as well as planned improvements.

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